

# International IR Rectifier

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PD - 95955

## IRL3803VpbF

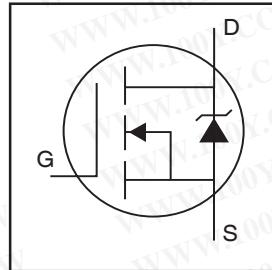
HEXFET® Power MOSFET

- Advanced Process Technology
- Ultra Low On-Resistance
- Dynamic dv/dt Rating
- 175°C Operating Temperature
- Fast Switching
- Fully Avalanche Rated
- Lead-Free

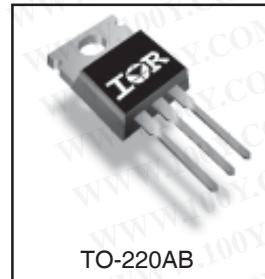
### Description

Advanced HEXFET® Power MOSFETs from International Rectifier utilize advanced processing techniques to achieve extremely low on-resistance per silicon area. This benefit, combined with the fast switching speed and ruggedized device design that HEXFET power MOSFETs are well known for, provides the designer with an extremely efficient and reliable device for use in a wide variety of applications.

The TO-220 package is universally preferred for all commercial-industrial applications at power dissipation levels to approximately 50 watts. The low thermal resistance and low package cost of the TO-220 contribute to its wide acceptance throughout the industry.



$V_{DSS} = 30V$   
 $R_{DS(on)} = 5.5m\Omega$   
 $I_D = 140A^{\circ}$



TO-220AB

### Absolute Maximum Ratings

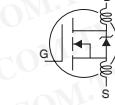
	Parameter	Max.	Units
$I_D @ T_C = 25^\circ C$	Continuous Drain Current, $V_{GS} @ 10V$	140 $\circ$	A
$I_D @ T_C = 100^\circ C$	Continuous Drain Current, $V_{GS} @ 10V$	110	
$I_{DM}$	Pulsed Drain Current <sup>①</sup>	470	
$P_D @ T_C = 25^\circ C$	Power Dissipation	200	W
	Linear Derating Factor	1.4	W/ $^\circ C$
$V_{GS}$	Gate-to-Source Voltage	$\pm 16$	V
$I_{AR}$	Avalanche Current <sup>①</sup>	71	A
$E_{AR}$	Repetitive Avalanche Energy <sup>①</sup>	20	mJ
$dv/dt$	Peak Diode Recovery $dv/dt$ <sup>③</sup>	5.0	V/ns
$T_J$	Operating Junction and	$-55$ to $+175$	
$T_{STG}$	Storage Temperature Range	$^\circ C$	
	Soldering Temperature, for 10 seconds		
	Mounting torque, 6-32 or M3 screw	300 (1.6mm from case )	
		10 lbf $\cdot$ in (1.1N $\cdot$ m)	

### Thermal Resistance

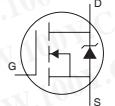
	Parameter	Typ.	Max.	Units
$R_{\theta JC}$	Junction-to-Case	—	0.74	$^\circ C/W$
$R_{\theta CS}$	Case-to-Sink, Flat, Greased Surface	0.50	—	
$R_{\theta JA}$	Junction-to-Ambient	—	62	

# IRL3803VPbF

## Electrical Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

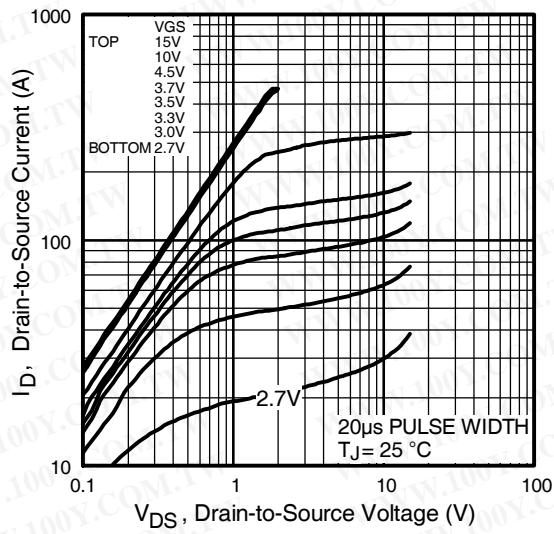
	Parameter	Min.	Typ.	Max.	Units	Conditions
$V_{(\text{BR})\text{DSS}}$	Drain-to-Source Breakdown Voltage	30	—	—	V	$V_{\text{GS}} = 0\text{V}$ , $I_D = 250\mu\text{A}$
$\Delta V_{(\text{BR})\text{DSS}/\Delta T_J}$	Breakdown Voltage Temp. Coefficient	—	0.028	—	V/ $^\circ\text{C}$	Reference to $25^\circ\text{C}$ , $I_D = 1\text{mA}$
$R_{\text{DS}(\text{on})}$	Static Drain-to-Source On-Resistance	—	—	5.5	m $\Omega$	$V_{\text{GS}} = 10\text{V}$ , $I_D = 71\text{A}$ ④
		—	—	7.5		$V_{\text{GS}} = 4.5\text{V}$ , $I_D = 59\text{A}$ ④
$V_{\text{GS}(\text{th})}$	Gate Threshold Voltage	1.0	—	—	V	$V_{\text{DS}} = V_{\text{GS}}$ , $I_D = 250\mu\text{A}$
$g_{\text{fs}}$	Forward Transconductance	82	—	—	S	$V_{\text{DS}} = 25\text{V}$ , $I_D = 71\text{A}$ ④
$I_{\text{DSS}}$	Drain-to-Source Leakage Current	—	—	25	$\mu\text{A}$	$V_{\text{DS}} = 30\text{V}$ , $V_{\text{GS}} = 0\text{V}$
		—	—	250		$V_{\text{DS}} = 24\text{V}$ , $V_{\text{GS}} = 0\text{V}$ , $T_J = 150^\circ\text{C}$
$I_{\text{GSS}}$	Gate-to-Source Forward Leakage	—	—	100	nA	$V_{\text{GS}} = 16\text{V}$
	Gate-to-Source Reverse Leakage	—	—	-100		$V_{\text{GS}} = -16\text{V}$
$Q_g$	Total Gate Charge	—	—	76	nC	$I_D = 71\text{A}$
$Q_{\text{gs}}$	Gate-to-Source Charge	—	—	19		$V_{\text{DS}} = 24\text{V}$
$Q_{\text{gd}}$	Gate-to-Drain ("Miller") Charge	—	—	35		$V_{\text{GS}} = 4.5\text{V}$ , See Fig. 6 and 13
$t_{\text{d}(\text{on})}$	Turn-On Delay Time	—	16	—		$V_{\text{DD}} = 15\text{V}$
$t_r$	Rise Time	—	180	—		$I_D = 71\text{A}$
$t_{\text{d}(\text{off})}$	Turn-Off Delay Time	—	29	—		$R_G = 1.3\Omega$
$t_f$	Fall Time	—	37	—		$V_{\text{GS}} = 4.5\text{V}$ , See Fig. 10 ④
$L_D$	Internal Drain Inductance	—	4.5	—	nH	Between lead, 6mm (0.25in.) from package and center of die contact
$L_S$	Internal Source Inductance	—	7.5	—		
$C_{\text{iss}}$	Input Capacitance	—	3720	—	pF	$V_{\text{GS}} = 0\text{V}$
$C_{\text{oss}}$	Output Capacitance	—	1480	—		$V_{\text{DS}} = 25\text{V}$
$C_{\text{rss}}$	Reverse Transfer Capacitance	—	270	—		$f = 1.0\text{MHz}$ , See Fig. 5
$E_{\text{AS}}$	Single Pulse Avalanche Energy②	—	1560③	400⑥	mJ	$I_{\text{AS}} = 71\text{A}$ , $L = 0.16\text{mH}$

## Source-Drain Ratings and Characteristics

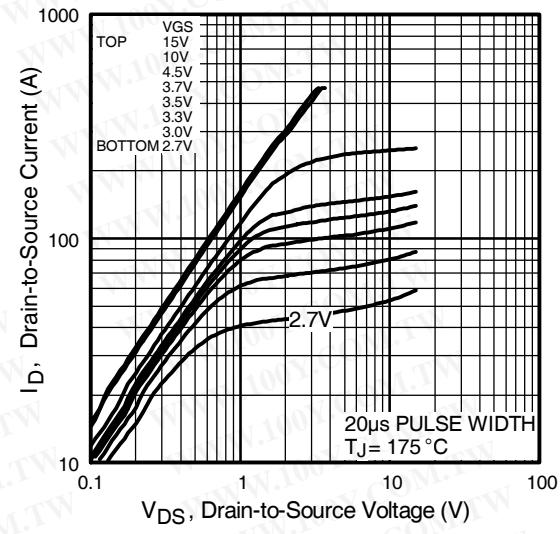
	Parameter	Min.	Typ.	Max.	Units	Conditions
$I_S$	Continuous Source Current (Body Diode)	—	—	140⑦	A	MOSFET symbol showing the integral reverse p-n junction diode.
$I_{\text{SM}}$	Pulsed Source Current (Body Diode)①	—	—	470		
$V_{\text{SD}}$	Diode Forward Voltage	—	—	1.2	V	$T_J = 25^\circ\text{C}$ , $I_S = 71\text{A}$ , $V_{\text{GS}} = 0\text{V}$ ④
$t_{\text{rr}}$	Reverse Recovery Time	—	52	78	ns	$T_J = 25^\circ\text{C}$ , $I_F = 71\text{A}$
$Q_{\text{rr}}$	Reverse Recovery Charge	—	91	140	nC	$dI/dt = 100\text{A}/\mu\text{s}$ ④
$t_{\text{on}}$	Forward Turn-On Time	Intrinsic turn-on time is negligible (turn-on is dominated by $L_S+L_D$ )				

### Notes:

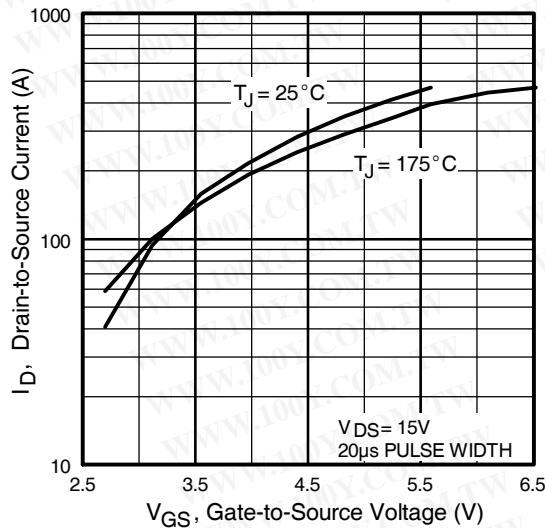
- ① Repetitive rating; pulse width limited by max. junction temperature. (See fig. 11)
- ② Starting  $T_J = 25^\circ\text{C}$ ,  $L = 160\mu\text{H}$   
 $R_G = 25\Omega$ ,  $I_{\text{AS}} = 71\text{A}$ ,  $V_{\text{GS}}=10\text{V}$  (See Figure 12)
- ③  $I_{\text{SD}} \leq 71\text{A}$ ,  $dI/dt \leq 110\text{A}/\mu\text{s}$ ,  $V_{\text{DD}} \leq V_{(\text{BR})\text{DSS}}$ ,  
 $T_J \leq 175^\circ\text{C}$
- ④ Pulse width  $\leq 400\mu\text{s}$ ; duty cycle  $\leq 2\%$ .
- ⑤ This is a typical value at device destruction and represents operation outside rated limits.
- ⑥ This is a calculated value limited to  $T_J = 175^\circ\text{C}$ .
- ⑦ Calculated continuous current based on maximum allowable junction temperature. Package limitation current is 75A.



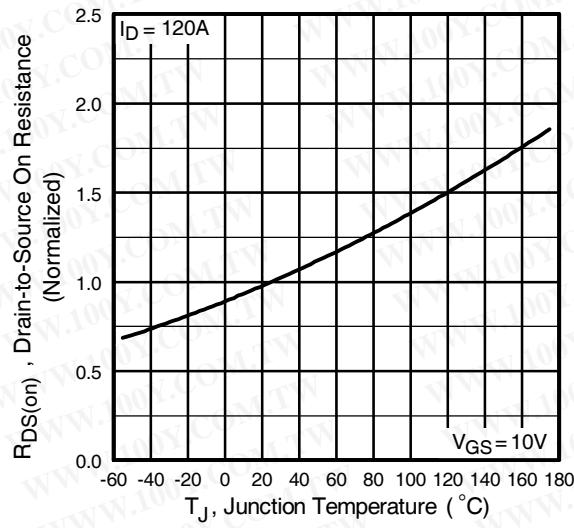
**Fig 1.** Typical Output Characteristics



**Fig 2.** Typical Output Characteristics

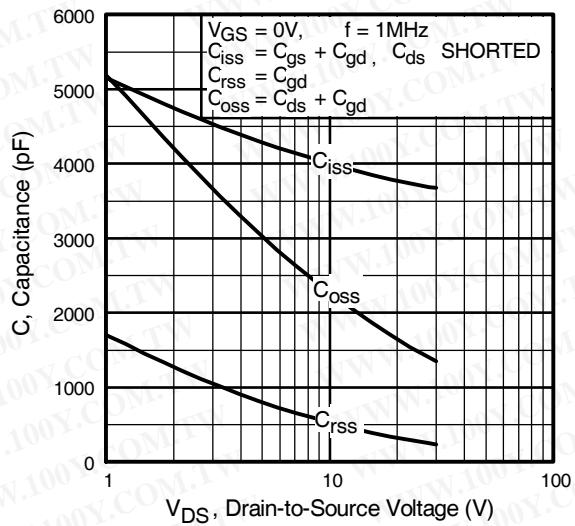


**Fig 3.** Typical Transfer Characteristics

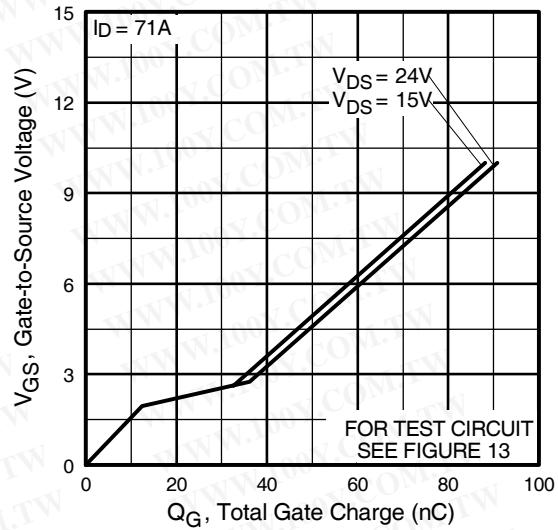


**Fig 4.** Normalized On-Resistance  
Vs. Temperature

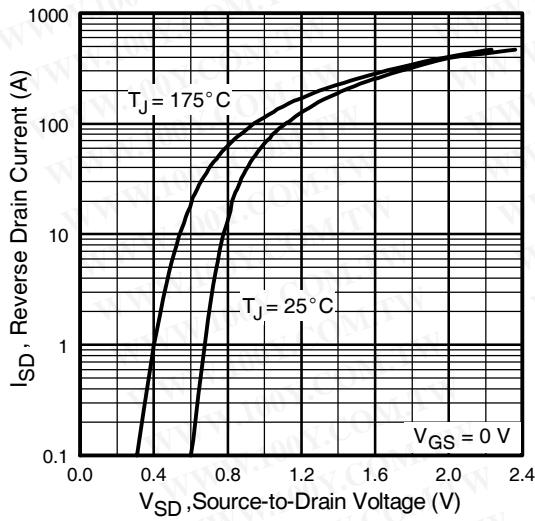
# IRL3803VPbF



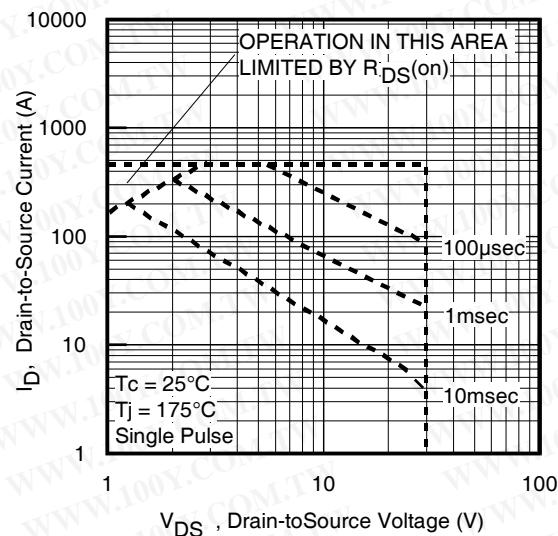
**Fig 5.** Typical Capacitance Vs.  
Drain-to-Source Voltage



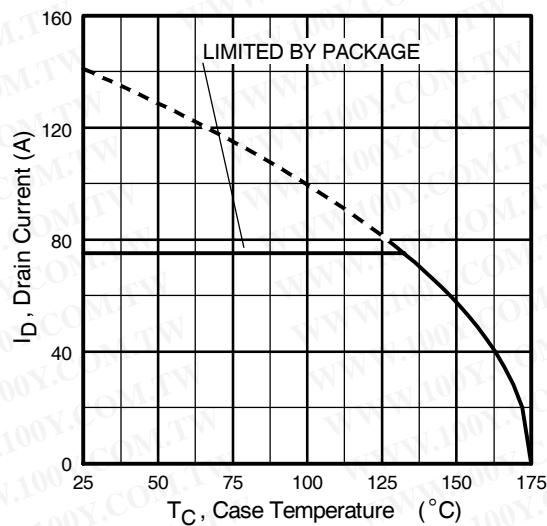
**Fig 6.** Typical Gate Charge Vs.  
Gate-to-Source Voltage



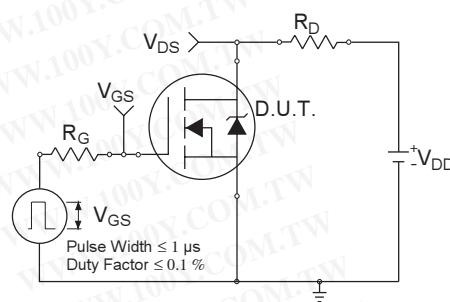
**Fig 7.** Typical Source-Drain Diode  
Forward Voltage



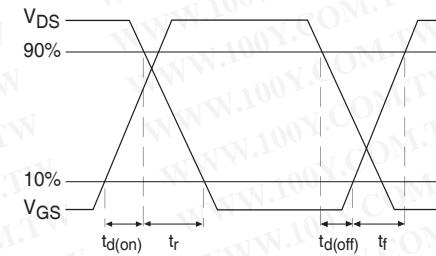
**Fig 8.** Maximum Safe Operating Area



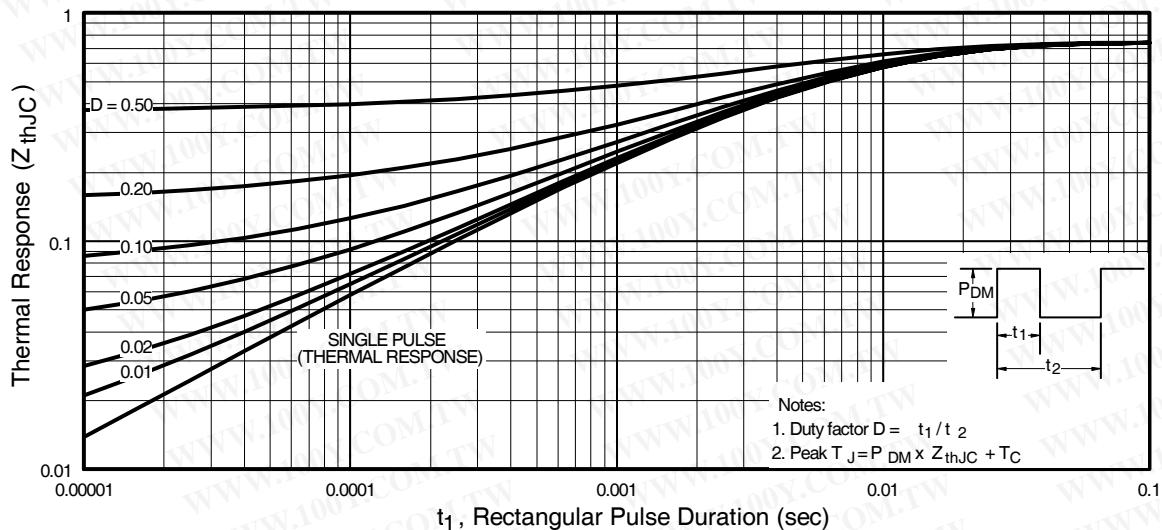
**Fig 9.** Maximum Drain Current Vs.  
Case Temperature



**Fig 10a.** Switching Time Test Circuit



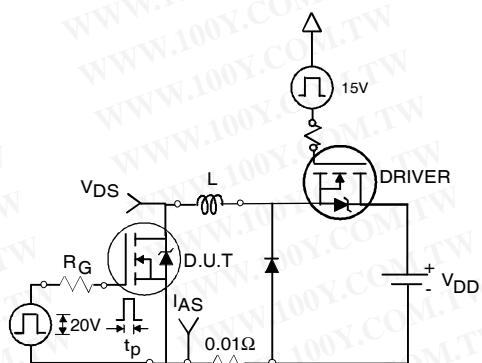
**Fig 10b.** Switching Time Waveforms



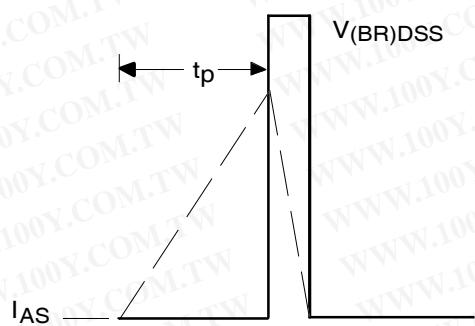
**Fig 11.** Maximum Effective Transient Thermal Impedance, Junction-to-Case

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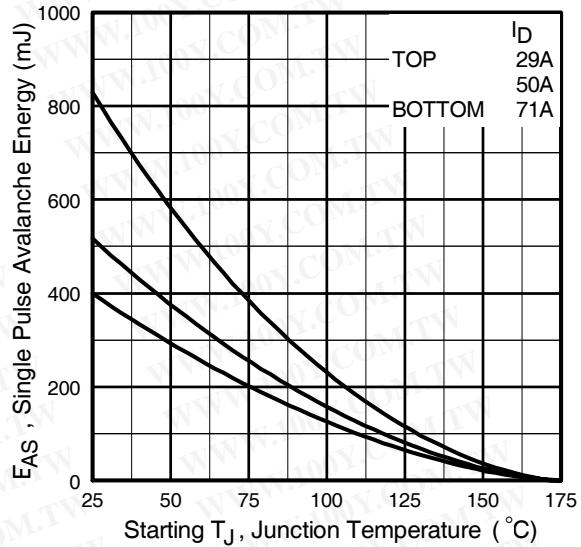
International  
Rectifier



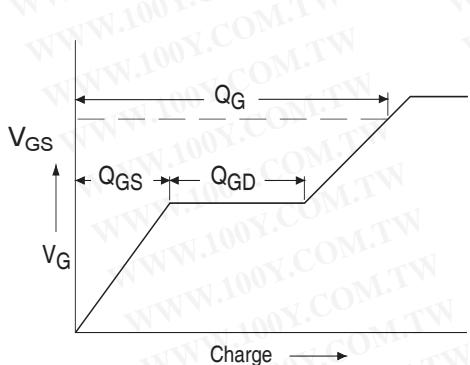
**Fig 12a.** Unclamped Inductive Test Circuit



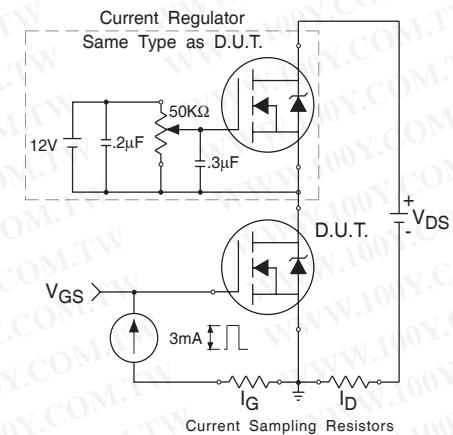
**Fig 12b.** Unclamped Inductive Waveforms



**Fig 12c.** Maximum Avalanche Energy Vs. Drain Current

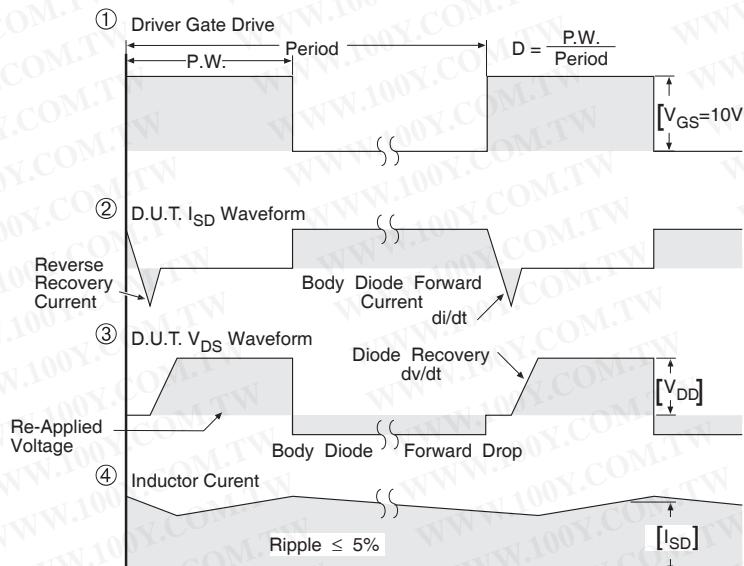
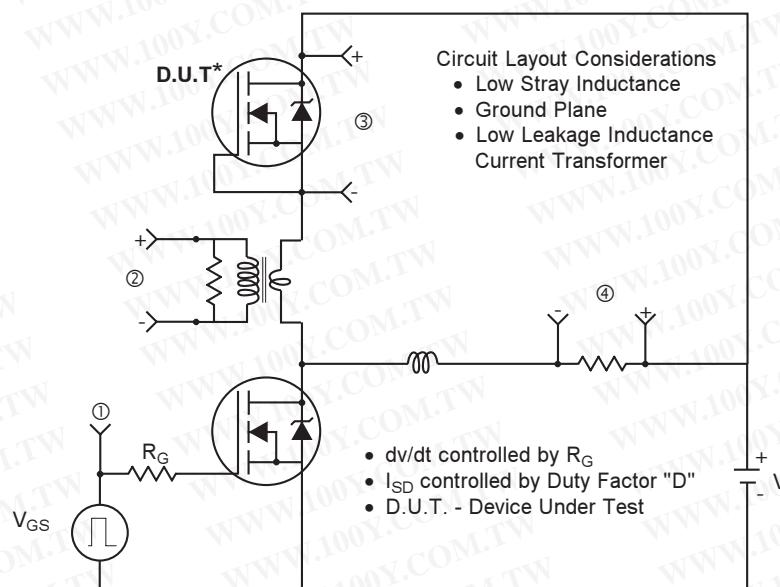


**Fig 13a.** Basic Gate Charge Waveform



**Fig 13b.** Gate Charge Test Circuit

## Peak Diode Recovery dv/dt Test Circuit

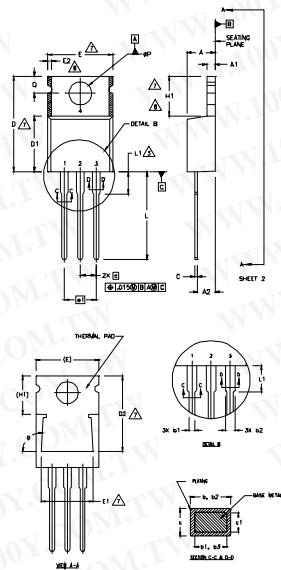


\*\*\*  $V_{GS} = 5.0V$  for Logic Level and 3V Drive Devices

**Fig 14.** For N-channel HEXFET® power MOSFETs

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## TO-220AB Package Outline



NOTES	DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994.															
	1. DIMENSIONS ARE SHOWN IN INCHES (MILLIMETERS).															
2. LEAD DIMENSION AND FINISH UNCONTROLLED IN L1.																
3. DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH IS UNCONTROLLED. THESE DIMENSIONS ARE MEASURED AT THE OLDESTNESS EXTREMES OF THE PLASTIC BODY.																
4. DIMENSION A & E ARE MEASURED AT THE OLDESTNESS EXTREMES OF THE PLASTIC BODY.																
5. CONTROLLED DIMENSION : INCHES.																
6. THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSIONS E1,H1,02 & E1																
7. DIMENSION E2 X H1 DEFINING A ZONE FOR STAMPING AND SCAFFOLDING REQUIREMENTS ARE ALLOWED.																
8. SHEET 2																

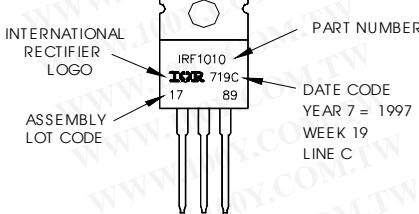
### LAD ASSIGNMENTS

NETLIST  
1 - GATE  
2 - DRAIN  
3 - SOURCE

CIRCUIT SYMBOL  
1 - GATE  
2 - COLLECTOR  
3 - Emitter

INDEXES  
1 - ANODE OPEN  
2 - CATHODE  
3 - GND

SYMBOL	DIMENSIONS		NOTES
	MILLIMETERS	INCHES	
A	3.56	.142	
A1	.051	.020	.055
A2	2.04	.292	.080
b	0.38	.011	.040
b1	0.38	.096	.015
b2	1.15	.077	.045
b3	1.15	.077	.045
c	0.35	.014	.008
c1	0.36	.014	.022
D	14.22	.561	.560
D1	8.38	.902	.330
D2	12.19	1.286	.480
E	9.66	10.66	.567
E1	8.38	8.89	.420
2.04 .850		100 .050	
e1	5.08	2.00	.050
H1	5.85	6.55	.230
L	12.70	14.73	.500
L1	-	6.35	.250
RP	5.54	4.08	.139
O	2.54	3.42	.161
g	90°-93°	90°-93°	.135



**TO-220AB package is not recommended for Surface Mount Application.**

Data and specifications subject to change without notice.  
 This product has been designed and qualified for the Industrial market.  
 Qualification Standards can be found on IR's Web site.

International  
**IR** Rectifier

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